

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

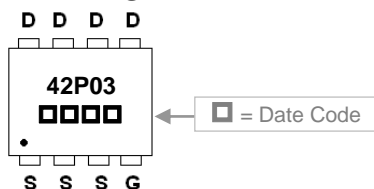
DESCRIPTION

The SSPR42P03-C provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness. The SPR-8PP package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

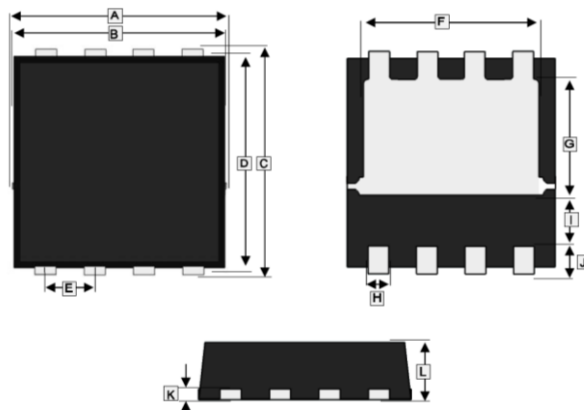
FEATURES

- Lower Gate Charge
- Simple Drive Requirement
- Fast Switching Characteristic

MARKING



SPR-8PP



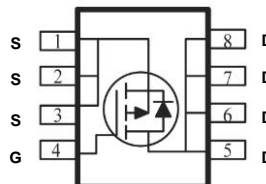
REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	3.00	3.40	G	1.35	1.98
B	3.00	3.25	H	0.24	0.35
C	3.20	3.45	I	0.35 TYP.	
D	3.00	3.20	J	0.60 TYP.	
E	0.65 BSC.		K	0.10	0.25
F	2.39	2.60	L	0.70	0.90

PACKAGE INFORMATION

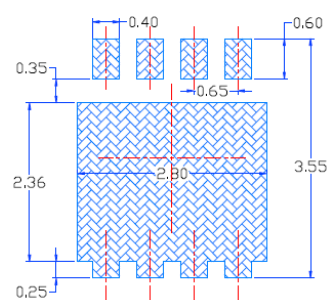
Package	MPQ	Leader Size
SPR-8PP	3K	13 inch

ORDER INFORMATION

Part Number	Type
SSPR42P03-C	Lead (Pb)-free and Halogen-free



Mounting Pad Layout



*Dimensions in millimeters

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹ @ $V_{GS}=10\text{V}$	I_D	$T_C=25^\circ\text{C}$	-42
		$T_C=100^\circ\text{C}$	-27
Pulsed Drain Current ²	I_{DM}	-130	A
Single Pulse Avalanche Energy ³	E_{AS}	264	mJ
Avalanche Current	I_{AS}	-42	A
Power Dissipation ⁴	P_D	37	W
Operating Junction & Storage Temperature	T_J, T_{STG}	-55~150	$^\circ\text{C}$
Thermal Resistance Rating			
Thermal Resistance Junction-Ambient ¹ (Max.)	$R_{\theta JA}$	75	$^\circ\text{C/W}$
Thermal Resistance Junction-Case ¹ (Max.)	$R_{\theta JC}$	3.38	

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ C$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Drain-Source Breakdown Voltage	BV_{DSS}	-30	-	-	V	$V_{GS}=0, I_D = -250\mu A$	
Gate-Threshold Voltage	$V_{GS(th)}$	-1	-	-2.5	V	$V_{DS}=V_{GS}, I_D = -250\mu A$	
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{GS} = \pm 20V$	
Drain-Source Leakage Current	I_{DSS}	$T_J=25^\circ C$	-	-	-1	uA	$V_{DS} = -24V, V_{GS}=0$
		$T_J=55^\circ C$	-	-	-5		
Static Drain-Source On-Resistance ²	$R_{DS(ON)}$	-	-	15	m Ω	$V_{GS} = -10V, I_D = -30A$	
		-	-	25		$V_{GS} = -4.5V, I_D = -15A$	
Gate Resistance	R_g	-	9	18	Ω	$f=1MHz$	
Total Gate Charge	Q_g	-	19.6	-	nC	$I_D = -15A$ $V_{DS} = -15V$ $V_{GS} = -4.5V$	
Gate-Source Charge	Q_{gs}	-	9.2	-			
Gate-Drain ("Miller") Charge	Q_{gd}	-	6.2	-			
Turn-on Delay Time ²	$T_{d(on)}$	-	7.3	-	nS	$V_{DD} = -15V$ $I_D = -15A$ $V_{GS} = -10V$ $R_G = 3.3\Omega$	
Rise Time	T_r	-	2.9	-			
Turn-off Delay Time	$T_{d(off)}$	-	72.8	-			
Fall Time	T_f	-	44.2	-			
Input Capacitance	C_{iss}	-	2555	-	pF	$V_{GS}=0$ $V_{DS} = -15V$ $f=1MHz$	
Output Capacitance	C_{oss}	-	297	-			
Reverse Transfer Capacitance	C_{rss}	-	204	-			
Single Pulse Avalanche Energy ⁵	E_{AS}	66	-	-	mJ	$V_{DD} = -25V, L=0.1mH,$ $I_{AS} = -21A$	
Source-Drain Diode							
Diode Forward Voltage ²	V_{SD}	-	-	-1	V	$I_S = -1A, V_{GS}=0, T_J=25^\circ C$	
Continuous Source Current ^{1 6}	I_S	-	-	-42	A	$V_D=V_G=0, \text{Force Current}$	
Pulsed Source Current ^{2 6}	I_{SM}	-	-	-130	A		
Reverse Recovery Time	T_{rr}	-	19	-	nS	$I_F = -15A, di/dt=100A/\mu s,$ $T_J=25^\circ C$	
Reverse Recovery Charge	Q_{rr}	-	9	-	nC		

Notes:

- The data tested by surface mounted on a 1 inch² FR-4 board with 2oz copper, $\leq 10sec, 125^\circ C/W$ at steady state.
- The data tested by pulsed, pulse width $\leq 300\mu s, \text{duty cycle} \leq 2\%$.
- The E_{AS} data shows Max. rating. The test condition is $V_{DD} = -25V, V_{GS} = -10V, L=0.1mH, I_{AS} = -42A$.
- The power dissipation is limited by $150^\circ C$ junction temperature.
- The Min. value is 100% E_{AS} tested guarantee.
- The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

CHARACTERISTIC CURVES

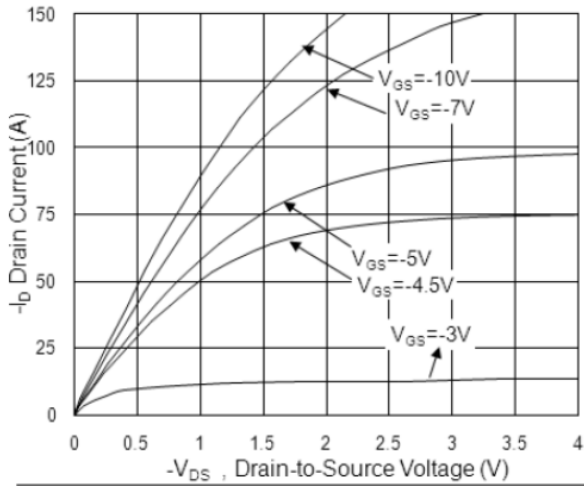


Fig.1 Typical Output Characteristics

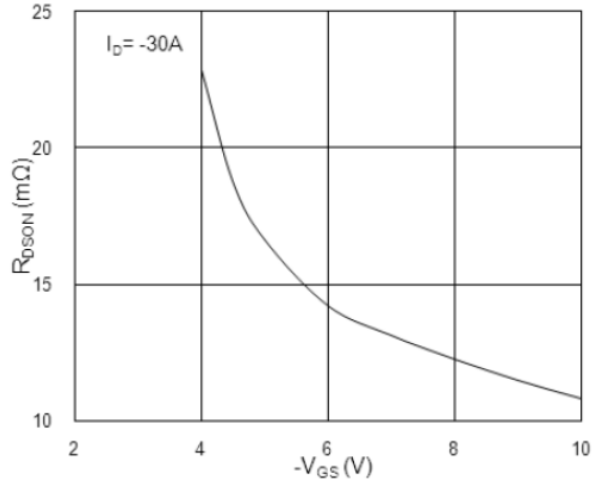


Fig.2 On-Resistance vs. G-S Voltage

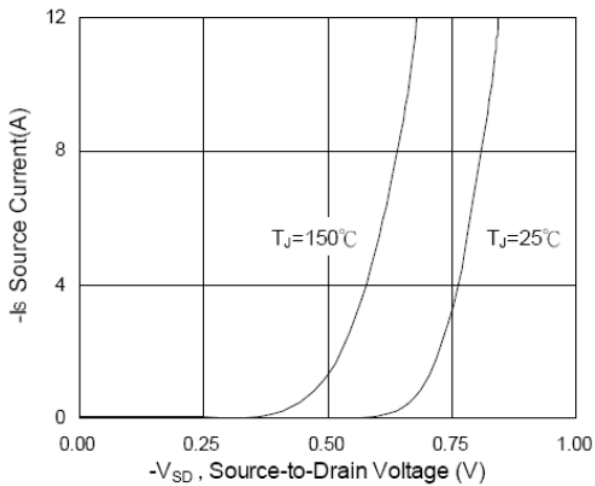


Fig.3 Forward Characteristics of Reverse

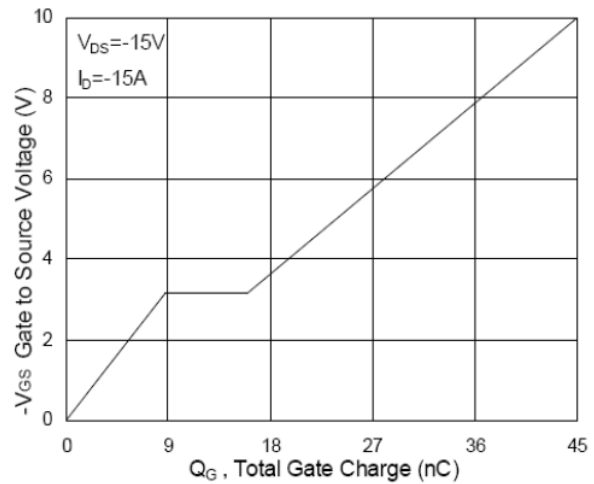


Fig.4 Gate-charge Characteristics

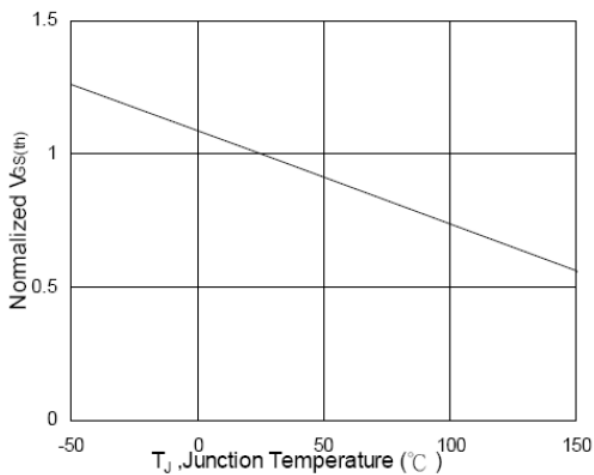


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

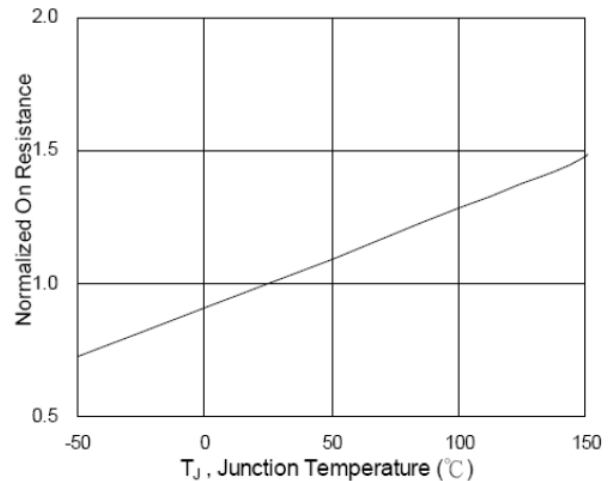


Fig.6 Normalized $R_{DS(ON)}$ vs. T_J

CHARACTERISTIC CURVES

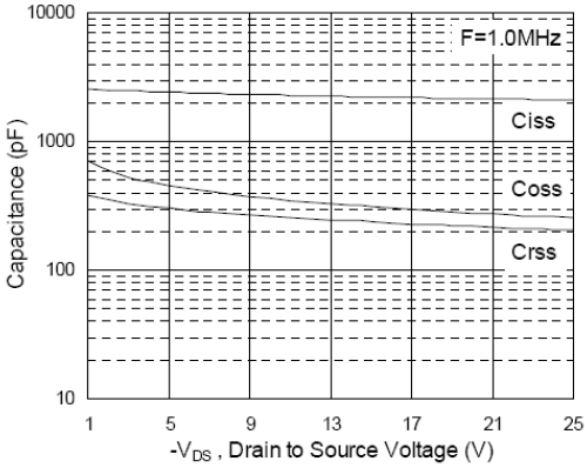


Fig.7 Capacitance

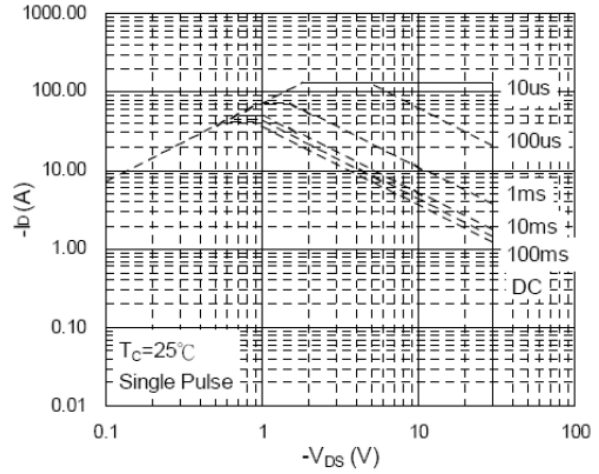


Fig.8 Safe Operating Area

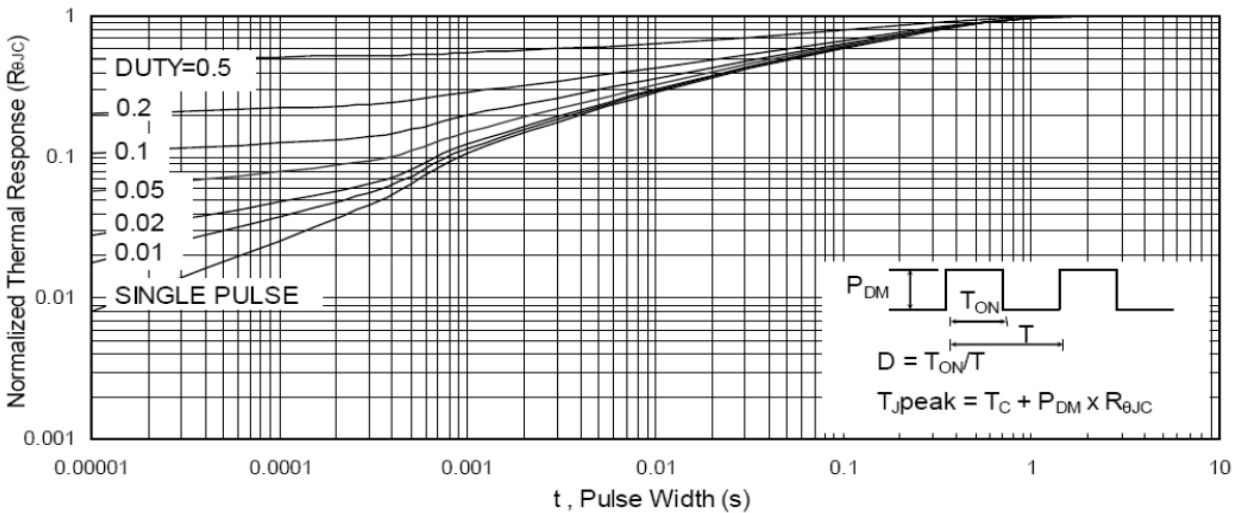


Fig.9 Normalized Maximum Transient Thermal Impedance

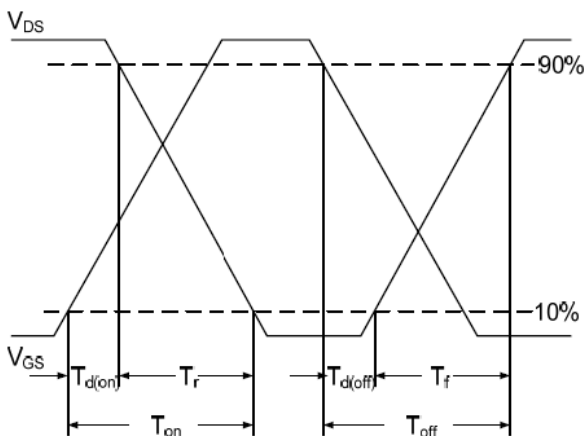


Fig.10 Switching Time Waveform

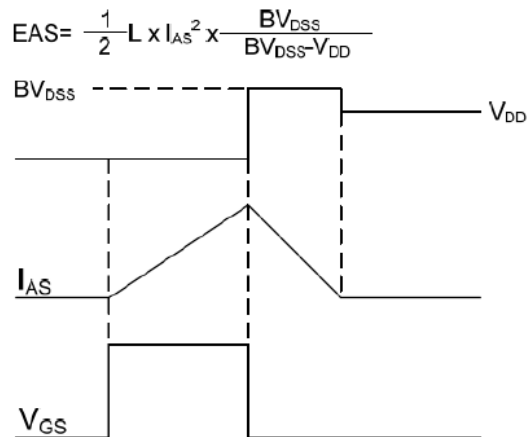


Fig.11 Unclamped Inductive Switching Wave